

N-Channel 100-V (D-S) MOSFET

Description

The device is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- $R_{DS(ON)} = 48m\Omega@V_{GS} = 10V$
- Low Reverse Transfer Capacitance
- High Switching Speed
- 100% EAS Guaranteed
- Green Device Available

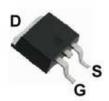
Typical Applications

- Networking
- Load Switch
- LED Applications

Package type: TO-252

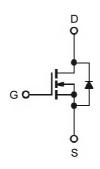
Packing & Order Information

3,000/Reel

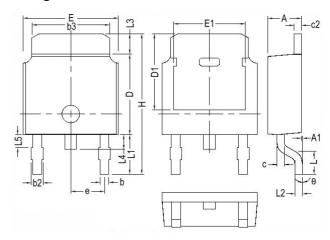


RoHS Compliant

Graphic Symbol

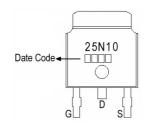


Package Dimension



REF.	Millimeter		REF.	Millimeter		r			
	Min.	Nom.	Max.	IXLI.	Min.	Nom.	Max.		
Α	2.20	2.30	2.38	E1	4.40	-	-		
A1	0	-	0.127	е	2.286 BSC				
b	0.64	0.76	0.88	Ι	9.40 10.00		10.40		
b2	0.77	0.84	1.14	L	1.40	1.52	1.77		
b3	5.21	5.34	5.46	L1	2.743 Ref.				
С	0.45	0.50	0.60	L2	0.508 BSC				
c2	0.45	0.50	0.58	L3	0.89 -		1.27		
D	6.00	6.10	6.223	L4	0.64 -		1.01		
D1	5.21	-	-	L5	-	-	-		
Е	6.40	6.60	6.731	θ	0°	-	10°		

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
V_{DS}	Drain-Source Voltage	100	V		
V _{GS}	Gate-Source Voltage	±20	V		
1	Continuous Drain Current ¹ (T _C =25°C)	25	А		
I _D	Continuous Drain Current ¹ (T _C =100°C)	15	А		
I _{DM}	Pulsed Drain Current ^{1,2}	100	А		
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	23	Α		
E _{AS}	Single Pulse Avalanche Energy, L =0.1mH ³	26.4	mJ		
D	Power Dissipation ⁴ (T _C =25°C)	60	W		
P_D	Power Dissipation ⁴ (T _A =25°C)	2	W		
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings						
Symbol	Parameter	Maximum	Units			
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62.5	°C/W			
R _{0JC}	Maximum Junction-to-Case ¹	2.1	°C/W			

Electrical Characteristics (T _J =25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
$V_{GS\ (th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	1.0	1.7	2.5	V
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250 \mu A$	100	-	-	V
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =80V, V _{GS} =0V, T _J =25°C V _{DS} =80V, V _{GS} =0V, T _J =55°C	-	-	1 100	μA
R _{DS (on)}	Static Drain-Source On-Resistance ²	$V_{GS} = 10V, I_D = 25A$ $V_{GS} = 4.5V, I_D = 15A$	-	-	48 50	mΩ
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =10A	5	-	-	mJ
V _{SD}	Diode Forward Voltage ²	I _S =25A, V _{GS} =0V, T _J =25°C	-	-	1.0	V
Is	Continuous Source Current ^{1,6}	V _G =V _D =0V, Force Current	-	-	25	_
I _{SM}	Pulsed Source Current ^{2,6}		-	-	100	Α

Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =23A.
- 4. The power dissipation is limited by 150° C junction temperature.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



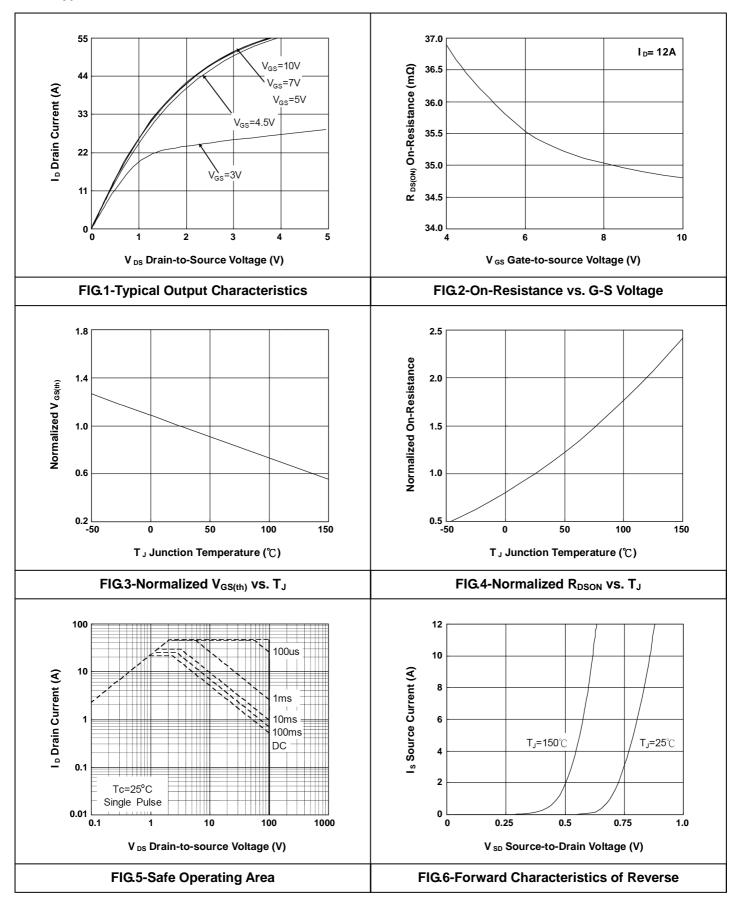
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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge ²	V _{DS} =80V		60		
Q _{gs}	Gate-Source Charge	I _D =20A		9.7		nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =10V		11.8		
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =50V		10.4		
t _r	Rise Time	I _D =20A		46		
t _{d(off)}	Turn-Off Delay Time	V _{GS} =10V		54		ns
t _f	Fall Time	$R_G = 3.3\Omega$		10		
C _{ISS}	Input Capacitance	V _{DS} =15V		3848		
Coss	Output Capacitance	V _{GS} =0V		137		pF
C _{RSS}	Reverse Transfer Capacitance	f =1.0MHz		82		1
Rg	Gate Resistance	V _{GS} =V _{DS} =0V, f =1.0MHz		1.6	3.2	Ω



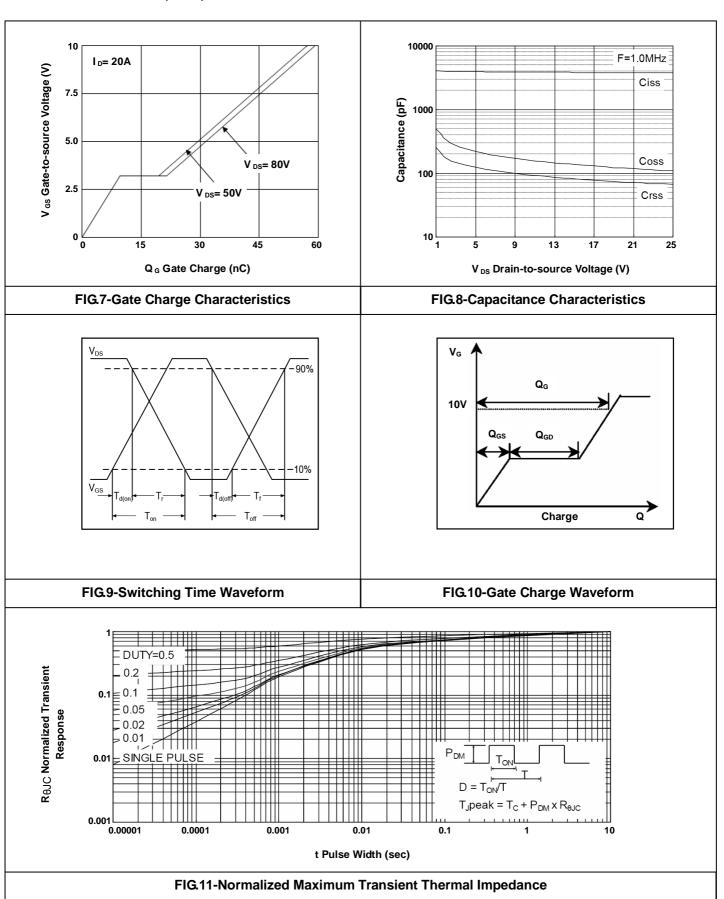
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Typical Electrical Characteristics





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